Notice of References Cited Application/Control No. 10/695,399 Applicant(s)/Patent Under Reexamination PHILLIPS ET AL. Examiner Uyen-Chau N. Le Applicant(s)/Patent Under Reexamination PHILLIPS ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,175,682 A	12-1992	Higashiyama et al.	705/45
	В	US-6,129,273 A	10-2000	Shah, Dinesh V.	235/380
	С	US-6,189,785 B1	02-2001	Lowery, Michael P.	235/379
	D	US-2002/0145035 A1	10-2002	Jones, John E.	235/379
	E	US-2003/0093368 A1	05-2003	Manfre et al.	705/39
	F	US-2003/0097332 A1	05-2003	Golasinski et al.	705/40
	G	US-6,644,546 B2	11-2003	George et al.	235/379
	Н	US-6,754,640 B2	06-2004	Bozeman, William O.	705/40
	1	US-2004/0133516 A1	07-2004	Buchanan et al.	705/042
	J	US-6,816,608 B2	11-2004	Cato, Robert Thomas	382/138
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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